Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
.10/625,818	SIMS, TYLER
Examiner	Art Unit

2874

Ellen Kim

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	SEAR	CHED	
Class	Subclass	Date	Examiner
385	18	5/11/2007	EK
210	175, 184	5/11/2007	EK
210	185	5/11/2007	EK
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
interferen	search, see ce search tout	5/11/2007	EK	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
East, NPL		5/11/2007	EK	